

STARPOWER

SEMICONDUCTOR

IGBT

GD400HTX75P7H

750V/400A 6 in one-package

General Description

STARPOWER IGBT Power Module provides ultra low conduction loss as well as short circuit ruggedness. They are designed for the applications such as hybrid and electric vehicles.

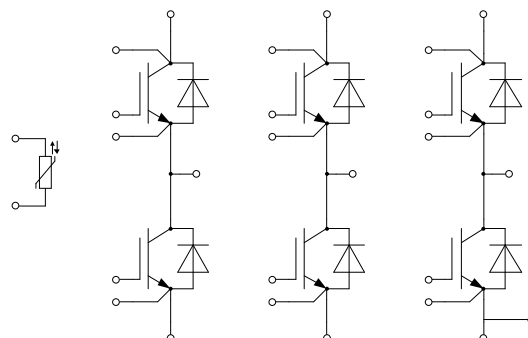
Features

- Low $V_{CE(sat)}$ Trench IGBT technology
- Low switching losses
- 6 μ s short circuit capability
- $V_{CE(sat)}$ with positive temperature coefficient
- Maximum junction temperature 175°C
- Low inductance case
- Fast & soft reverse recovery anti-parallel FWD
- Isolated copper pinfin baseplate using DBC technology

Typical Applications

- Automotive application
- Hybrid and electric vehicle
- Inverter for motor drive

Equivalent Circuit Schematic



Absolute Maximum Ratings $T_F=25^{\circ}\text{C}$ unless otherwise noted**IGBT**

Symbol	Description	Value	Unit
V_{CES}	Collector-Emitter Voltage	750	V
V_{GES}	Gate-Emitter Voltage	± 20	V
I_C	Collector Current @ $T_F=25^{\circ}\text{C}$	500	A
	@ $T_F=75^{\circ}\text{C}$	400	
I_{CM}	Pulsed Collector Current $t_p=1\text{ms}$	800	A
P_D	Maximum Power Dissipation @ $T_F=175^{\circ}\text{C}$	725	W

Diode

Symbol	Description	Value	Unit
V_{RRM}	Repetitive Peak Reverse Voltage	750	V
I_F	Diode Continuous Forward Current	400	A
I_{FM}	Diode Maximum Forward Current $t_p=1\text{ms}$	800	A

Module

Symbol	Description	Value	Unit
T_{vimax}	Maximum Junction Temperature	175	$^{\circ}\text{C}$
T_{vjop}	Operating Junction Temperature continuous	-40 to +150	$^{\circ}\text{C}$
	For 10s within a period of 30s, occurrence maximum 3000 times over lifetime	+150 to +175	
T_{STG}	Storage Temperature Range	-40 to +125	$^{\circ}\text{C}$
V_{ISO}	Isolation Voltage RMS, $f=50\text{Hz}$, $t=1\text{min}$	2500	V

IGBT Characteristics $T_F=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit	
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage	$I_C=400\text{A}, V_{GE}=15\text{V}, T_{vj}=25^\circ\text{C}$		1.40	1.85	V	
		$I_C=400\text{A}, V_{GE}=15\text{V}, T_{vj}=150^\circ\text{C}$		1.65			
		$I_C=400\text{A}, V_{GE}=15\text{V}, T_{vj}=175^\circ\text{C}$		1.70			
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	$I_C=6.40\text{mA}, V_{CE}=V_{GE}, T_{vj}=25^\circ\text{C}$	5.1	5.8	6.5	V	
I_{CES}	Collector Cut-Off Current	$V_{CE}=V_{CES}, V_{GE}=0\text{V}, T_{vj}=25^\circ\text{C}$			1.0	mA	
I_{GES}	Gate-Emitter Leakage Current	$V_{GE}=V_{GES}, V_{CE}=0\text{V}, T_{vj}=25^\circ\text{C}$			400	nA	
R_{Gint}	Internal Gate Resistance			1.0		Ω	
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}, f=100\text{kHz}, V_{GE}=0\text{V}$		28.2		nF	
C_{res}	Reverse Transfer Capacitance				1.04		nF
Q_G	Gate Charge	$V_{GE}=-15\dots+15\text{V}$		2.64		μC	
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=400\text{V}, I_C=400\text{A}, R_G=2.0\Omega, V_{GE}=\pm 15\text{V}, T_{vj}=25^\circ\text{C}$		195		ns	
t_r	Rise Time			60		ns	
$t_{d(off)}$	Turn-Off Delay Time			326		ns	
t_f	Fall Time			116		ns	
E_{on}	Turn-On Switching Loss			8.66		mJ	
E_{off}	Turn-Off Switching Loss			16.8		mJ	
$t_{d(on)}$	Turn-On Delay Time		$V_{CC}=400\text{V}, I_C=400\text{A}, R_G=2.0\Omega, V_{GE}=\pm 15\text{V}, T_{vj}=150^\circ\text{C}$		203		ns
t_r	Rise Time				64		ns
$t_{d(off)}$	Turn-Off Delay Time			378		ns	
t_f	Fall Time			189		ns	
E_{on}	Turn-On Switching Loss			14.3		mJ	
E_{off}	Turn-Off Switching Loss			22.2		mJ	
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=400\text{V}, I_C=400\text{A}, R_G=2.0\Omega, V_{GE}=\pm 15\text{V}, T_{vj}=175^\circ\text{C}$			206		ns
t_r	Rise Time				66		ns
$t_{d(off)}$	Turn-Off Delay Time			387		ns	
t_f	Fall Time			203		ns	
E_{on}	Turn-On Switching Loss			15.7		mJ	
E_{off}	Turn-Off Switching Loss			23.7		mJ	
I_{SC}	SC Data		$t_p \leq 6\mu\text{s}, V_{GE}=15\text{V}, T_{vj}=175^\circ\text{C}, V_{CC}=450\text{V}, V_{CEM} \leq 750\text{V}$		1700		A

Diode Characteristics $T_F=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V_F	Diode Forward Voltage	$I_F=400\text{A}, V_{GE}=0\text{V}, T_{vj}=25^\circ\text{C}$		1.55	2.00	V
		$I_F=400\text{A}, V_{GE}=0\text{V}, T_{vj}=150^\circ\text{C}$		1.50		
		$I_F=400\text{A}, V_{GE}=0\text{V}, T_{vj}=175^\circ\text{C}$		1.50		
Q_r	Recovered Charge	$V_R=400\text{V}, I_F=400\text{A},$ $-di/dt=6120\text{A}/\mu\text{s}, V_{GE}=-15\text{V}$ $T_{vj}=25^\circ\text{C}$		7.90		μC
I_{RM}	Peak Reverse Recovery Current			192		A
E_{rec}	Reverse Recovery Energy			3.66		mJ
Q_r	Recovered Charge	$V_R=400\text{V}, I_F=400\text{A},$ $-di/dt=5450\text{A}/\mu\text{s}, V_{GE}=-15\text{V}$ $T_{vj}=150^\circ\text{C}$		20.1		μC
I_{RM}	Peak Reverse Recovery Current			240		A
E_{rec}	Reverse Recovery Energy			7.10		mJ
Q_r	Recovered Charge	$V_R=400\text{V}, I_F=400\text{A},$ $-di/dt=5270\text{A}/\mu\text{s}, V_{GE}=-15\text{V}$ $T_{vj}=175^\circ\text{C}$		24.2		μC
I_{RM}	Peak Reverse Recovery Current			258		A
E_{rec}	Reverse Recovery Energy			8.16		mJ

NTC Characteristics $T_F=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
R_{25}	Rated Resistance			5.0		$\text{k}\Omega$
$\Delta R/R$	Deviation of R_{100}	$T_C=100^\circ\text{C}, R_{100}=493.3\Omega$	-5		5	%
P_{25}	Power Dissipation				20.0	mW
$B_{25/50}$	B-value	$R_2=R_{25}\exp[B_{25/50}(1/T_2-1/(298.15\text{K}))]$		3375		K
$B_{25/80}$	B-value	$R_2=R_{25}\exp[B_{25/80}(1/T_2-1/(298.15\text{K}))]$		3411		K
$B_{25/100}$	B-value	$R_2=R_{25}\exp[B_{25/100}(1/T_2-1/(298.15\text{K}))]$		3433		K

Module Characteristics $T_F=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Min.	Typ.	Max.	Unit
ΔP	Pressure Drop Cooling Circuit $\Delta V/\Delta t=10.0\text{dm}^3/\text{min}; T_F=25^\circ\text{C};$ Cooling Fluid=50%Water/50%Ethylene Glycol		50		mbar
P	Maximum Pressure In Cooling Circuit			2.0	bar
R_{thJF}	Junction-to-Cooling Fluid (per IGBT) Junction-to-Cooling Fluid (per Diode)			0.207 0.291	K/W
M	Terminal Connection Torque, Screw M6 Mounting Torque, Screw M5	3.0 3.0		6.0 6.0	N.m
G	Weight of Module		685		g

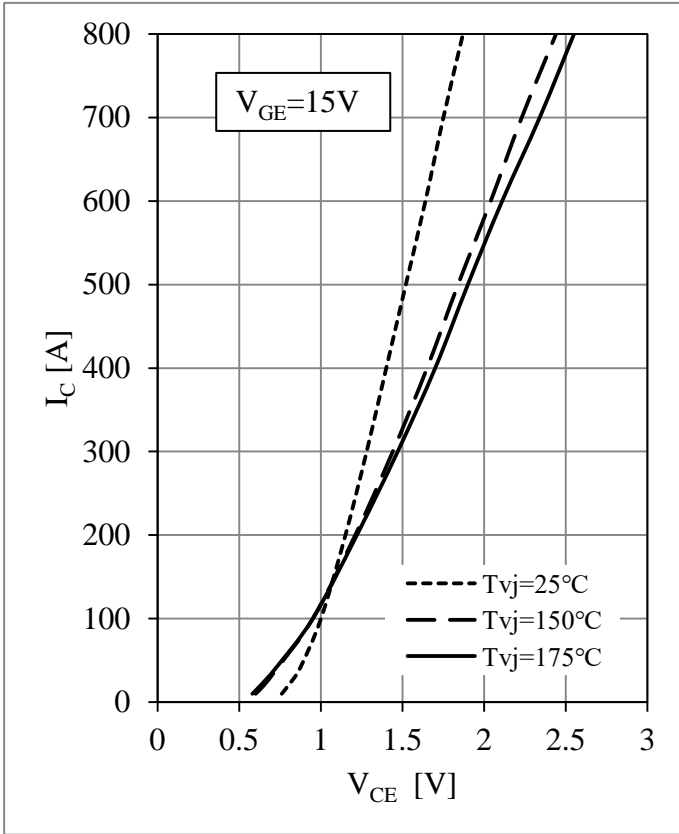


Fig 1. IGBT Output Characteristics

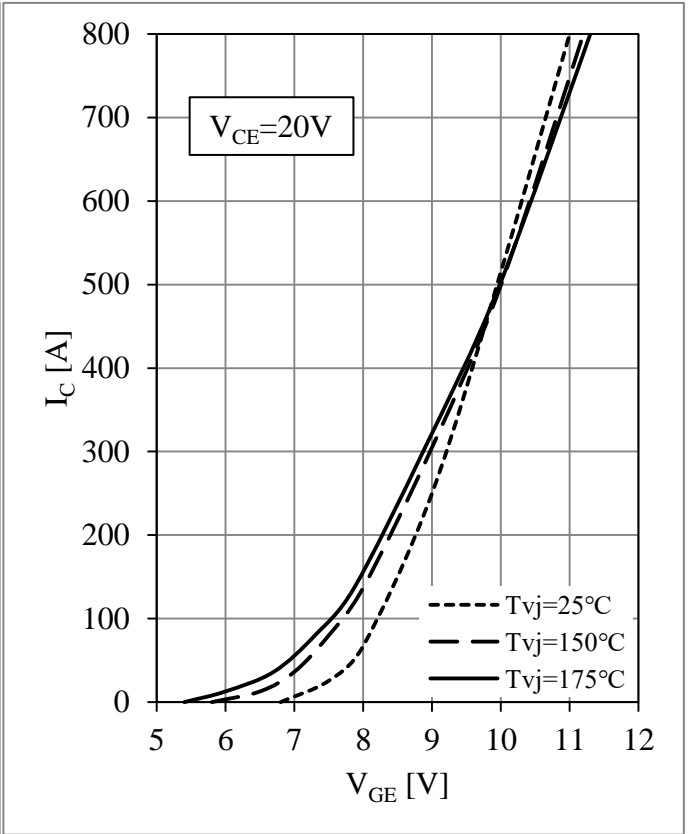


Fig 2. IGBT Transfer Characteristics

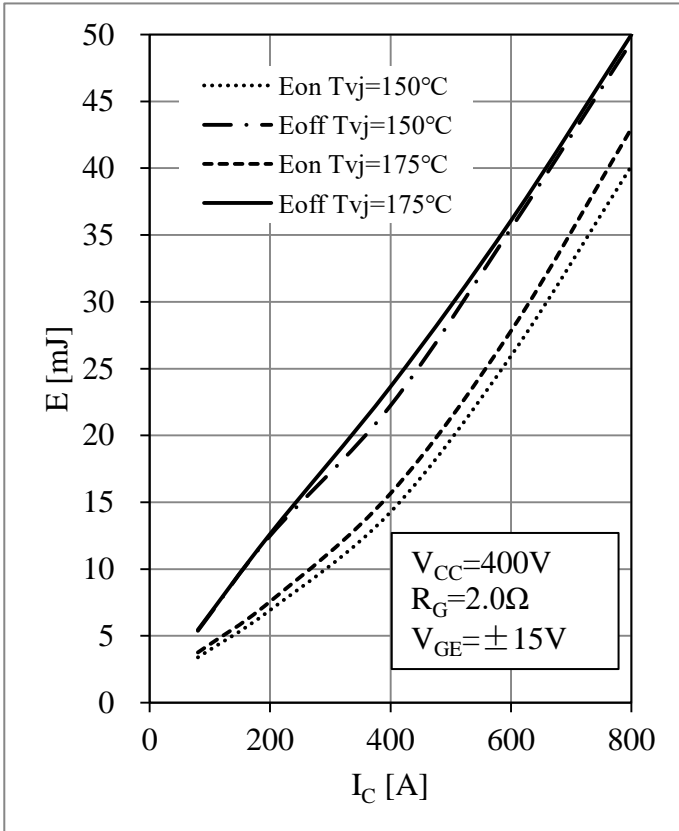


Fig 3. IGBT Switching Loss vs. I_C

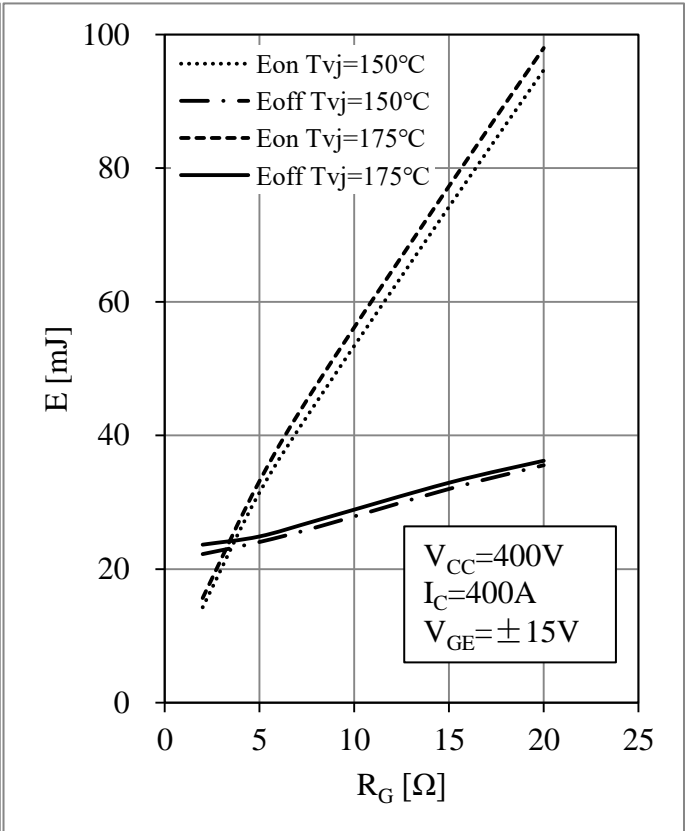


Fig 4. IGBT Switching Loss vs. R_G

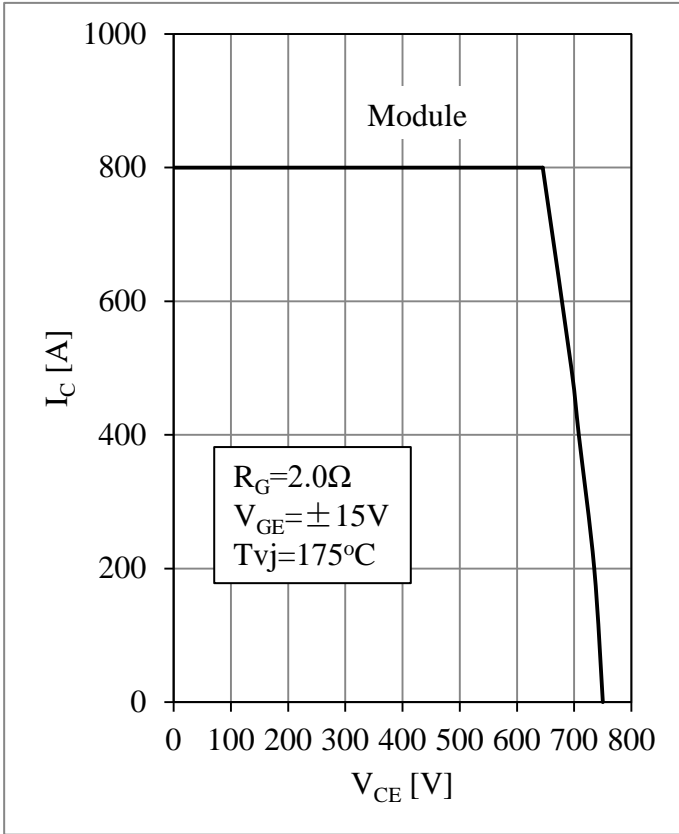


Fig 5. RBSOA

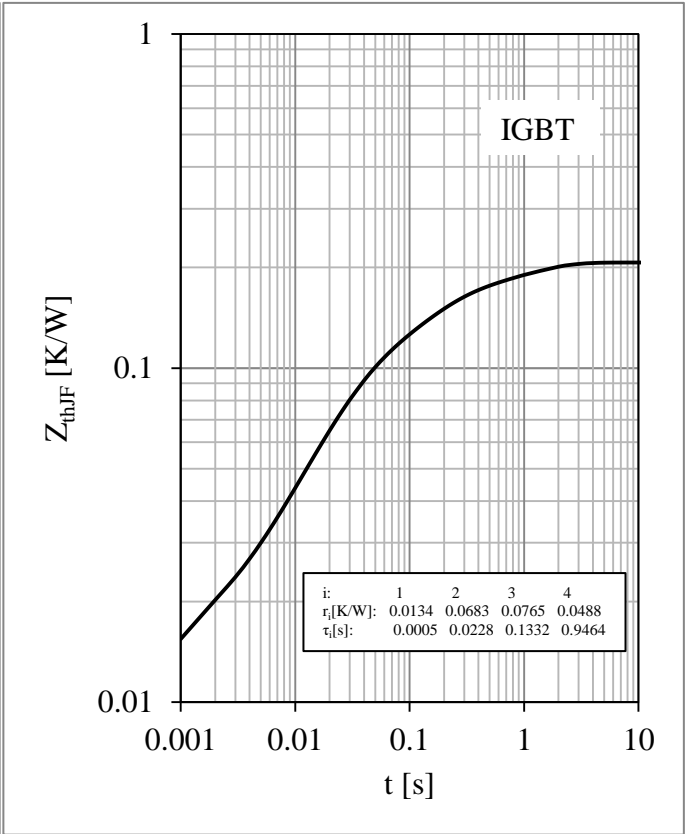


Fig 6. IGBT Transient Thermal Impedance

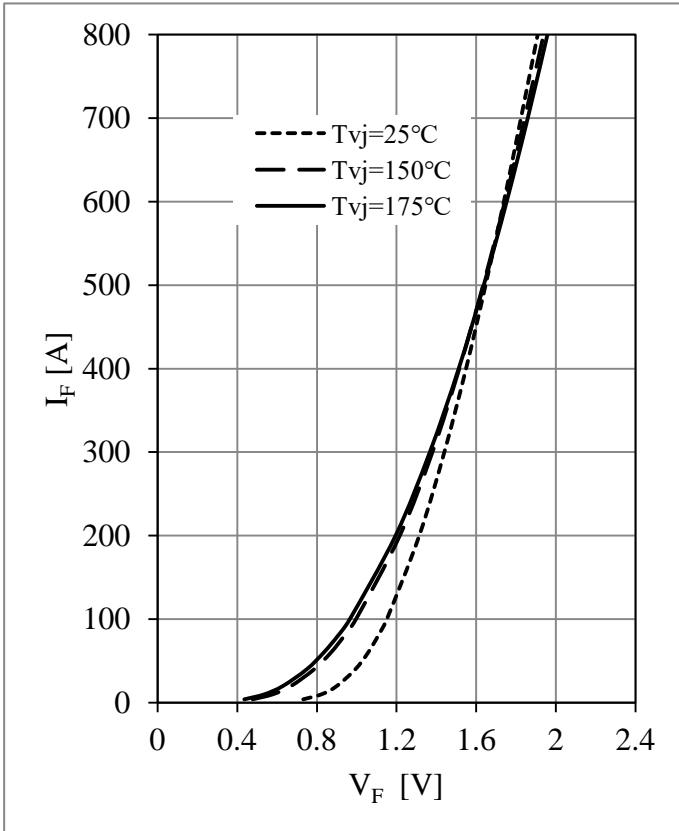


Fig 7. Diode Forward Characteristics

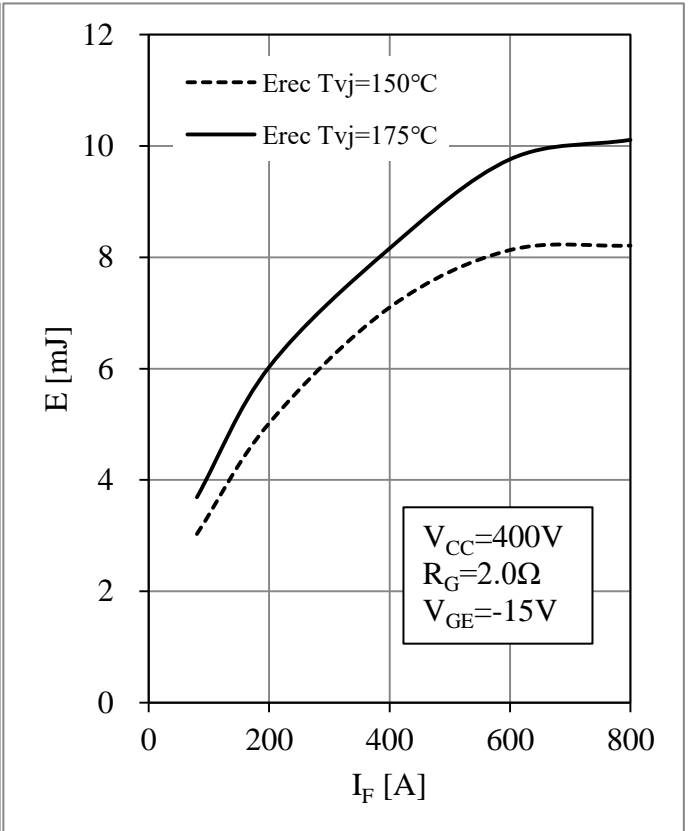


Fig 8. Diode Switching Loss vs. I_F

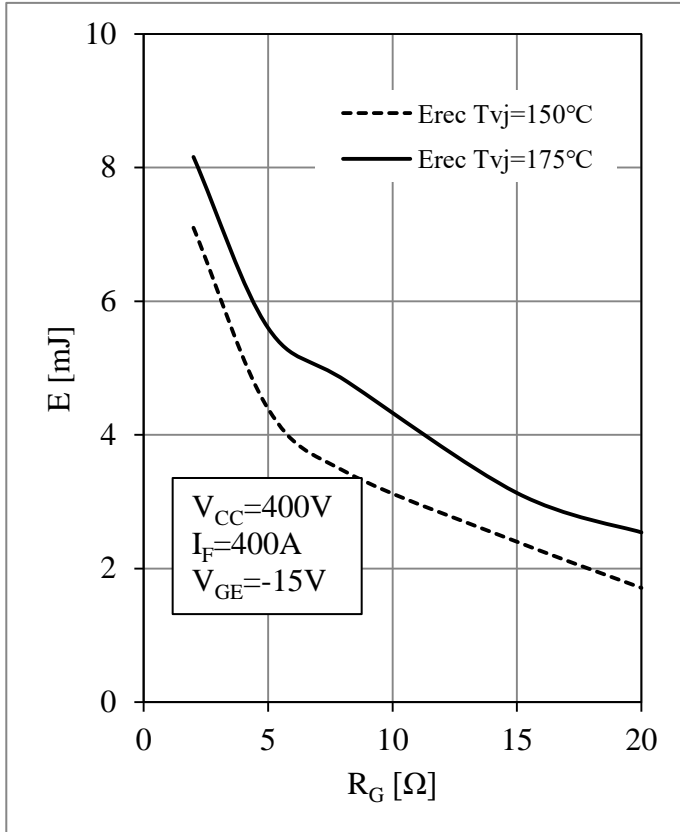


Fig 9. Diode Switching Loss vs. R_G

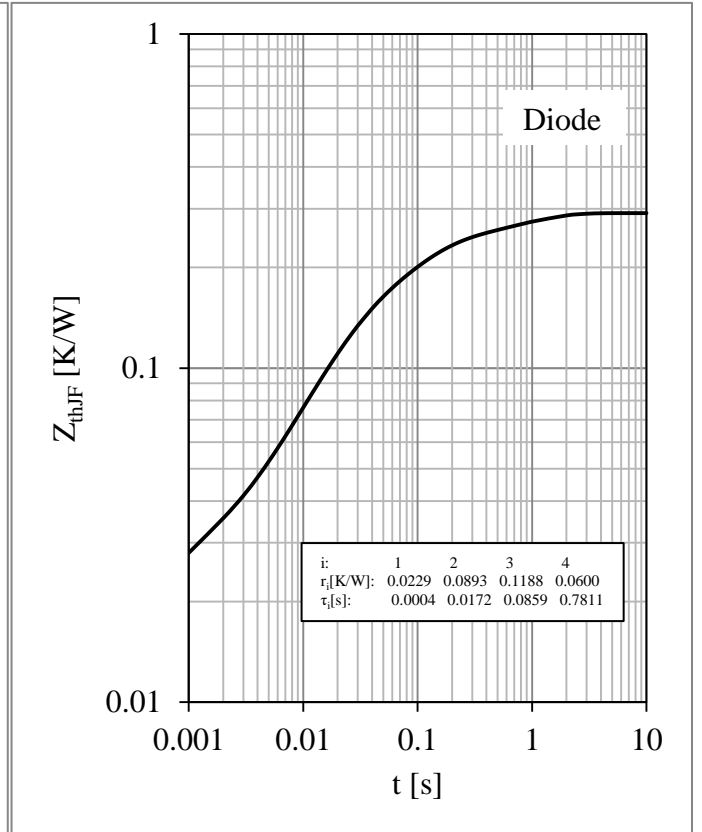


Fig 10. Diode Transient Thermal Impedance

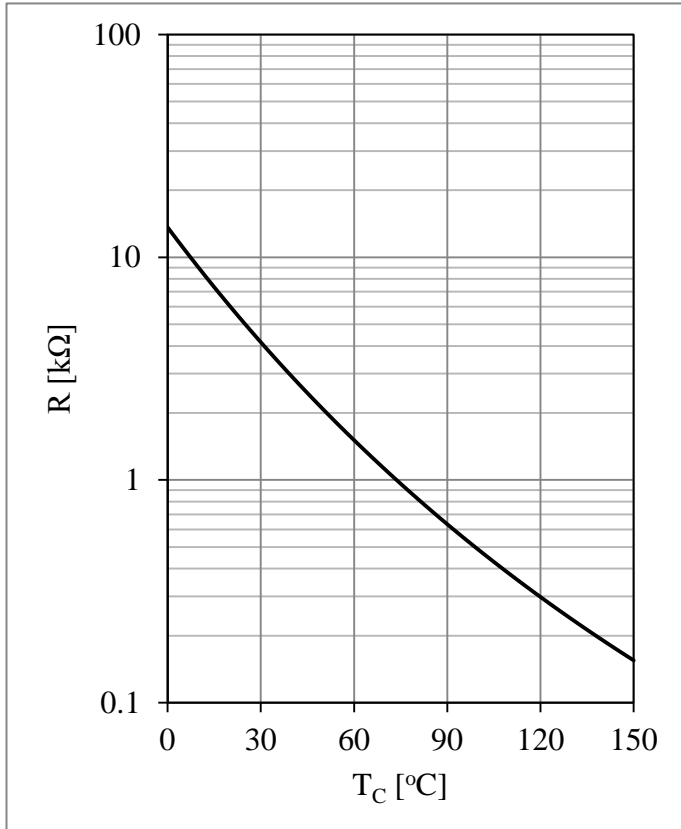
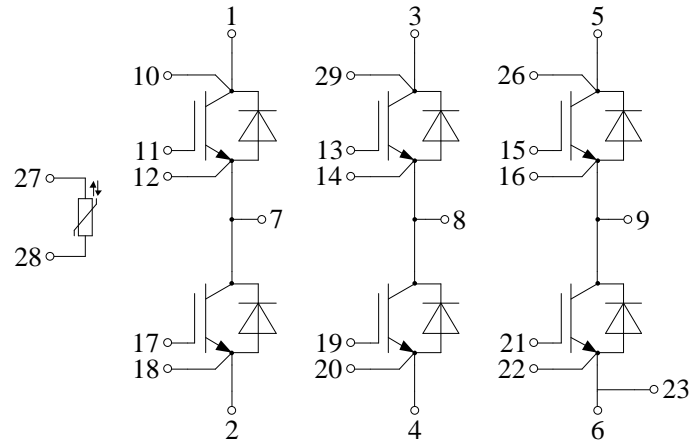


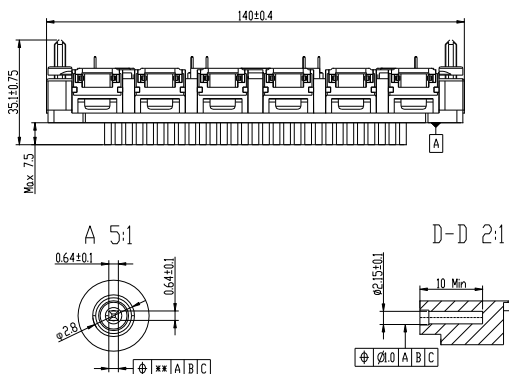
Fig 11. NTC Temperature Characteristic

Circuit Schematic

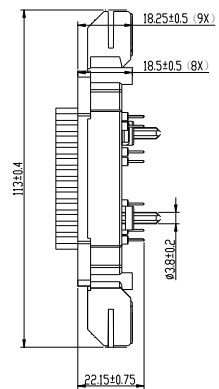
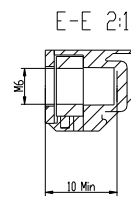
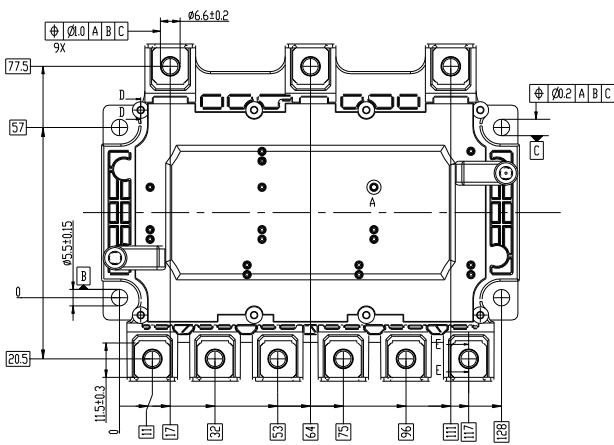
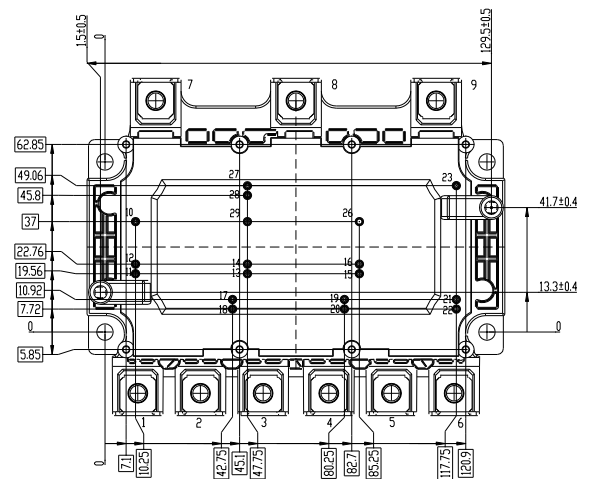


Package Dimensions

Dimensions in Millimeters



** Pin positions checked with pin gauge



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